

FORM PTO-1449 U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		Any. Docket No. 82842LMB Customer No. 01333		Serial No.	
If AFTER the later date of the first Office Action or 3 months from filing, use only with Rule 97(E) Certificate or Fee		Applicant: Jeffrey W. Leon, et al			
LIST OF ART CITED BY APPLICANT (Use several sheets if necessary)		Filing Date		Group	

1073 U.S. PTO
 10/027701
 12/20/01

U.S. PATENT DOCUMENTS						
Examiner Initial*	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
M	3,822,224	07/02/74	Gillan et al.			
	3,923,704	12/02/75	Gunning et al.			
	3,933,579	01/20/76	Kershaw et al.			
	3,979,342	09/07/76	Baidins et al.			
	4,089,819	05/16/78	Coates et al.			
	4,137,380	01/30/79	Gunning et al.			
M	4,363,888	12/14/82	Willison et al.			
FOREIGN PATENT DOCUMENTS						
Examiner Initial*	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
M	1395065	05/21/75	GB			X
	07-070331A	03/14/95	JP Kokai			X
	07-137432A	05/30/95	JP Kokai			X
	07-137433A	05/30/95	JP Kokai			X
M	07-179533A	07/18/95	JP Kokai			X
OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)						
M	Co-pending USSN 09/_____, Landry-Coltrain et al., <i>Small Porous Polyester Particles for Inkjet Use</i> (D-82966) 10/028,130					
M	Co-pending USSN 09/_____, Landry-Coltrain et al., <i>Multilayer Inkjet Recording Element With Porous Polyester Particles</i> (D-83466) 10/028,130					
EXAMINER <i>Tue Yoon</i>				DATE CONSIDERED <i>3-9-04</i>		

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

FORM PTO-1449		US DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		Atty. Docket No. 82842LMB Customer No. 01333		Serial No. 10/027,701	
If AFTER the later date of the first Office Action or 3 months from filing, use only with Rule 97(E) Certificate or Fee LIST OF ART CITED BY APPLICANT (Use several sheets if necessary)				Applicant: Jeffrey W. Leon, et al		RECEIVED AUG 19 2003 TC 1700	
				Filing Date 12/20/2001			
U.S. PATENT DOCUMENTS							
Examiner Initial*	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE	
FOREIGN PATENT DOCUMENTS							
Examiner Initial*	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO	
WJ	0 467 528 A2	01/22/92	EP				X
OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)							
Japanese Patent Abstract 06313021							
EXAMINER Tae Yoon				DATE CONSIDERED 3-9-04			
*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							